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With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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NGTG35N65FL2WG

IGBT - Field Stop II

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop II Trench construction, and provides superior performance in demanding switching applications, offering both low on state voltage and minimal switching loss. The IGBT is well suited for UPS and solar applications.

Features

- Extremely Efficient Trench with Field Stop Technology
- $T_{Jmax} = 175^{\circ}C$
- Optimized for High Speed Switching
- 5 μs Short-Circuit Capability
- These are Pb-Free Devices

Typical Applications

- Solar Inverters
- Uninterruptible Power Supplies (UPS)
- Welding

ABSOLUTE MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|--|-----------|-----------------|-------------|
| Collector-emitter voltage | V_{CES} | 650 | V |
| Collector current @ $T_c = 25^{\circ}C$ @ $T_c = 100^{\circ}C$ | I_c | 70 35 | A |
| Pulsed collector current, T_{pulse} limited by T_{Jmax} | I_{CM} | 120 | A |
| Short-circuit withstand time $V_{GE} = 15 V, V_{CE} = 400 V,$ $T_J \leq +150^{\circ}C$ | t_{SC} | 5 | μs |
| Gate-emitter voltage | V_{GE} | ± 20 | V |
| Transient gate-emitter voltage ($T_{PULSE} = 5 \mu s, D < 0.10$) | | ± 30 | V |
| Power Dissipation @ $T_c = 25^{\circ}C$ @ $T_c = 100^{\circ}C$ | P_D | 300 150 | W |
| Operating junction temperature range | T_J | -55 to $+175$ | $^{\circ}C$ |
| Storage temperature range | T_{stg} | -55 to $+175$ | $^{\circ}C$ |
| Lead temperature for soldering, 1/8" from case for 5 seconds | T_{SLD} | 260 | $^{\circ}C$ |

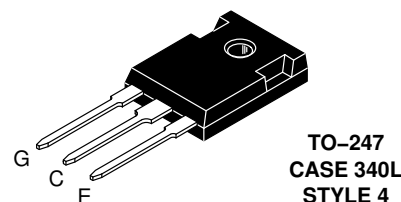
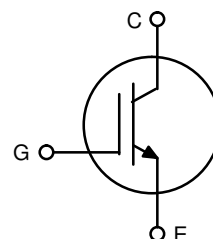
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



ON Semiconductor[®]

www.onsemi.com

35 A, 650 V
 $V_{CEsat} = 1.70 V$
 $E_{OFF} = 0.28 mJ$



MARKING DIAGRAM



A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

| Device | Package | Shipping |
|----------------|---------------------|-----------------|
| NGTG35N65FL2WG | TO-247 (Pb-Free) | 30 Units / Rail |

NGTG35N65FL2WG

THEMAL CHARACTERISTICS

| Rating | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Thermal resistance junction-to-case, for IGBT | $R_{\theta JC}$ | 0.50 | °C/W |
| Thermal resistance junction-to-ambient | $R_{\theta JA}$ | 40 | °C/W |

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

| Parameter | Test Conditions | Symbol | Min | Typ | Max | Unit |
|-----------|-----------------|--------|-----|-----|-----|------|
|-----------|-----------------|--------|-----|-----|-----|------|

STATIC CHARACTERISTIC

| | | | | | | |
|---|---|---------------|-----------|--------------|------------|----|
| Collector-emitter breakdown voltage, gate-emitter short-circuited | $V_{GE} = 0\text{ V}, I_C = 500\ \mu\text{A}$ | $V_{(BR)CES}$ | 650 | – | – | V |
| Collector-emitter saturation voltage | $V_{GE} = 15\text{ V}, I_C = 35\text{ A}$ $V_{GE} = 15\text{ V}, I_C = 35\text{ A}, T_J = 175^\circ\text{C}$ | V_{CEsat} | 1.50 – | 1.70 2.20 | 2.00 – | V |
| Gate-emitter threshold voltage | $V_{GE} = V_{CE}, I_C = 350\ \mu\text{A}$ | $V_{GE(th)}$ | 4.5 | 5.5 | 6.5 | V |
| Collector-emitter cut-off current, gate-emitter short-circuited | $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}$ $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}, T_J = 175^\circ\text{C}$ | I_{CES} | – – | – – | 0.5 4.0 | mA |
| Gate leakage current, collector-emitter short-circuited | $V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$ | I_{GES} | – | – | 200 | nA |

DYNAMIC CHARACTERISTIC

| | | | | | | |
|------------------------------|--|-----------|---|------|---|----|
| Input capacitance | $V_{CE} = 20\text{ V}, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$ | C_{ies} | – | 3115 | – | pF |
| Output capacitance | | C_{oes} | – | 149 | – | |
| Reverse transfer capacitance | | C_{res} | – | 88 | – | |
| Gate charge total | $V_{CE} = 480\text{ V}, I_C = 35\text{ A}, V_{GE} = 15\text{ V}$ | Q_g | – | 125 | – | nC |
| Gate to emitter charge | | Q_{ge} | – | 30 | – | |
| Gate to collector charge | | Q_{gc} | – | 63 | – | |

SWITCHING CHARACTERISTIC, INDUCTIVE LOAD

| | | | | | | | |
|-------------------------|--|--------------|-------|------|----|----|----|
| Turn-on delay time | $T_J = 25^\circ\text{C}$ $V_{CC} = 400\text{ V}, I_C = 35\text{ A}$ $R_g = 10\ \Omega$ $V_{GE} = 0\text{ V}/15\text{ V}^*$ | $t_{d(on)}$ | – | 72 | – | ns | |
| Rise time | | t_r | – | 40 | – | | |
| Turn-off delay time | | $t_{d(off)}$ | – | 132 | – | | |
| Fall time | | | t_f | – | 75 | – | mJ |
| Turn-on switching loss | | E_{on} | – | 0.84 | – | | |
| Turn-off switching loss | | E_{off} | – | 0.28 | – | | |
| Total switching loss | | E_{ts} | – | 1.12 | – | | |
| Turn-on delay time | $T_J = 150^\circ\text{C}$ $V_{CC} = 400\text{ V}, I_C = 35\text{ A}$ $R_g = 10\ \Omega$ $V_{GE} = 0\text{ V}/15\text{ V}^*$ | $t_{d(on)}$ | – | 70 | – | ns | |
| Rise time | | t_r | – | 38 | – | | |
| Turn-off delay time | | $t_{d(off)}$ | – | 135 | – | | |
| Fall time | | | t_f | – | 96 | – | mJ |
| Turn-on switching loss | | E_{on} | – | 1.05 | – | | |
| Turn-off switching loss | | E_{off} | – | 0.50 | – | | |
| Total switching loss | | E_{ts} | – | 1.55 | – | | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

*Includes diode reverse recovery loss using NGTG35N65FL2WG.

NGTG35N65FL2WG

TYPICAL CHARACTERISTICS

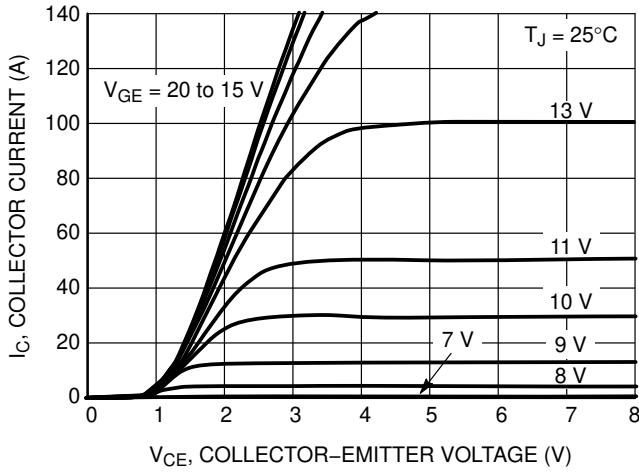


Figure 1. Output Characteristics

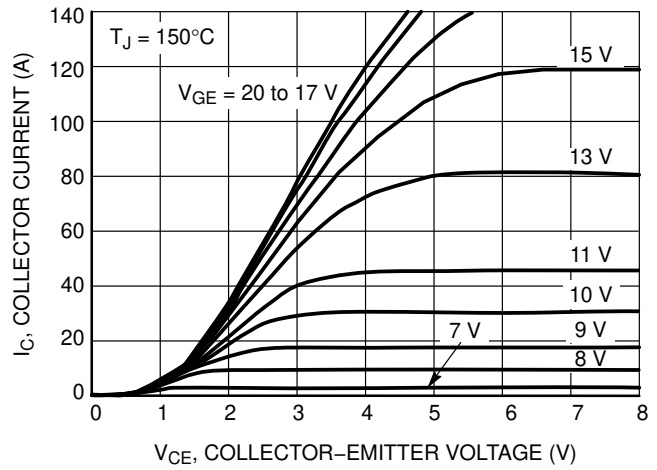


Figure 2. Output Characteristics

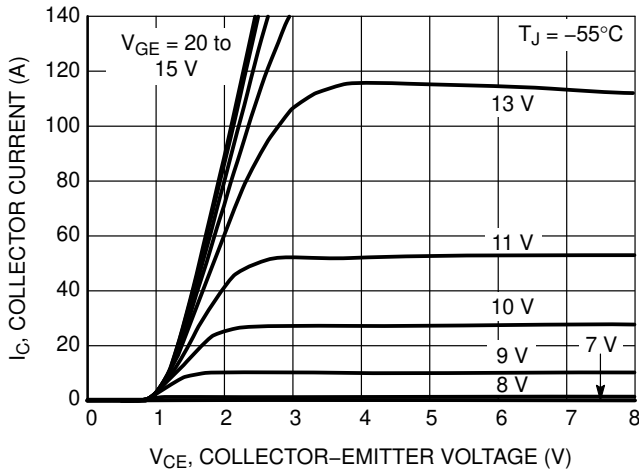


Figure 3. Output Characteristics

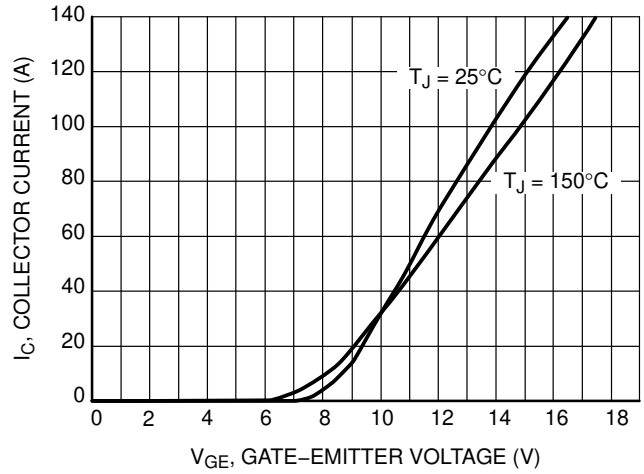


Figure 4. Typical Transfer Characteristics

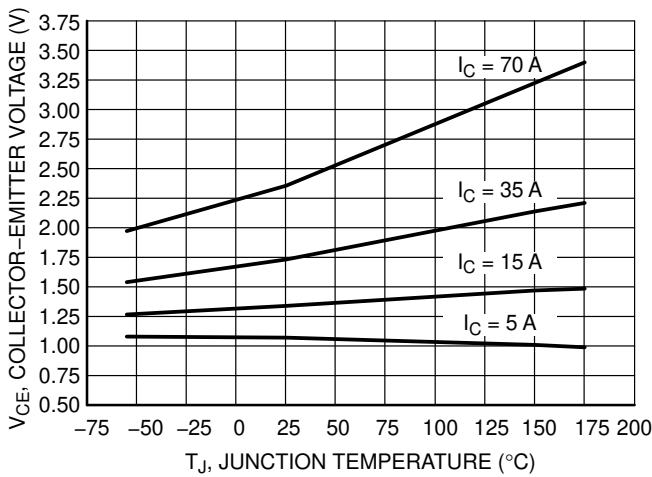


Figure 5. $V_{CE(sat)}$ vs. T_J

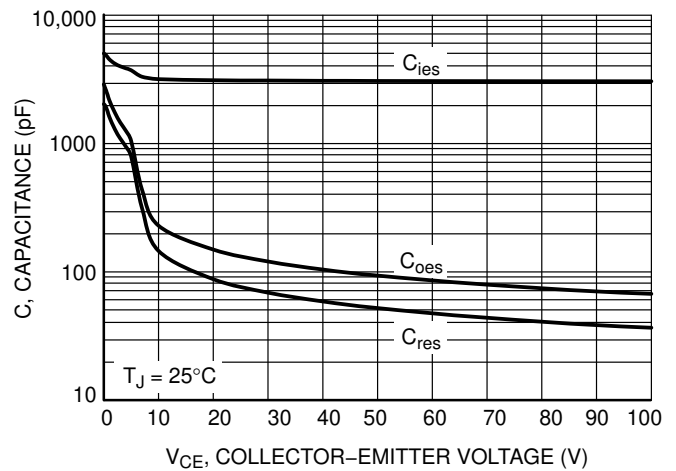


Figure 6. Typical Capacitance

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TYPICAL CHARACTERISTICS

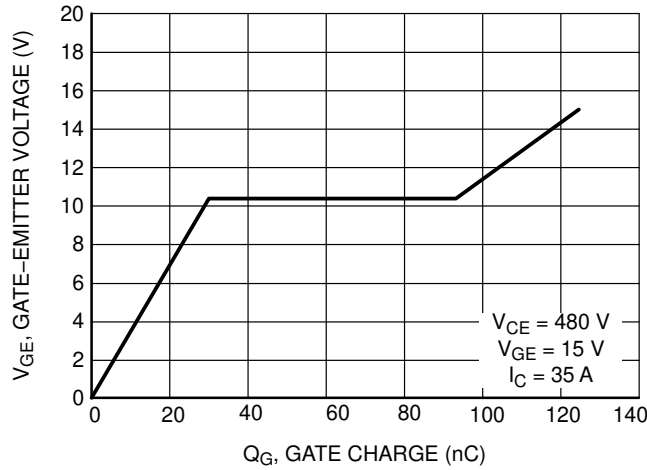


Figure 7. Typical Gate Charge

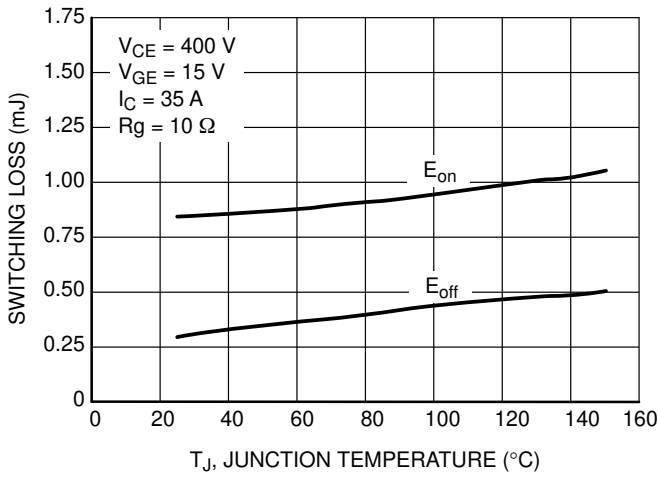


Figure 8. Switching Loss vs. Temperature

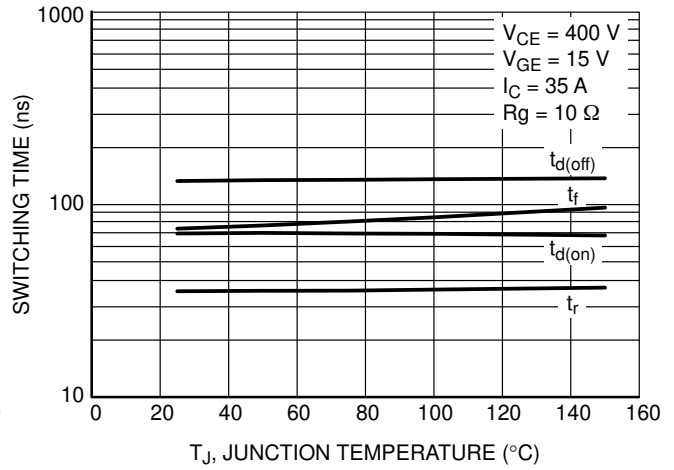


Figure 9. Switching Time vs. Temperature

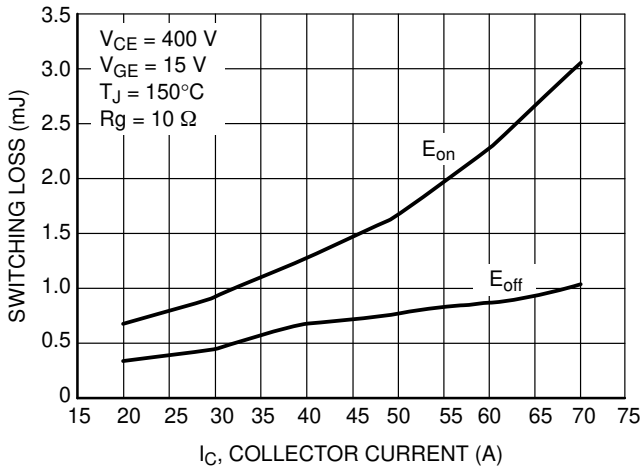


Figure 10. Switching Loss vs. I_C

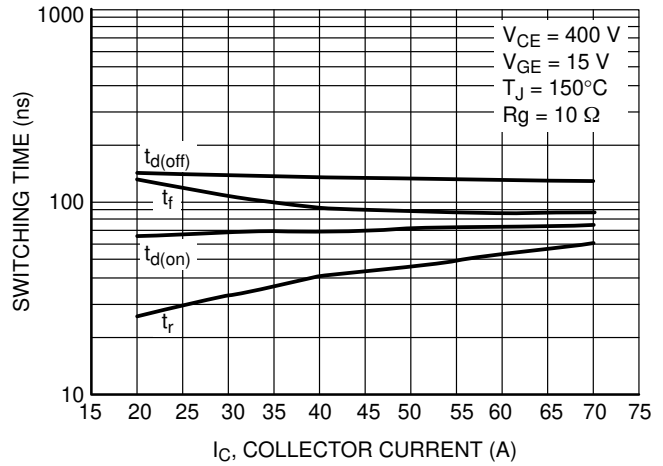


Figure 11. Switching Time vs. I_C

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TYPICAL CHARACTERISTICS

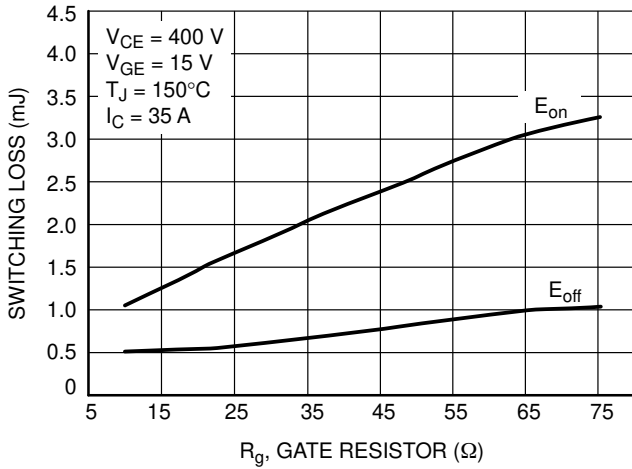


Figure 12. Switching Loss vs. R_g

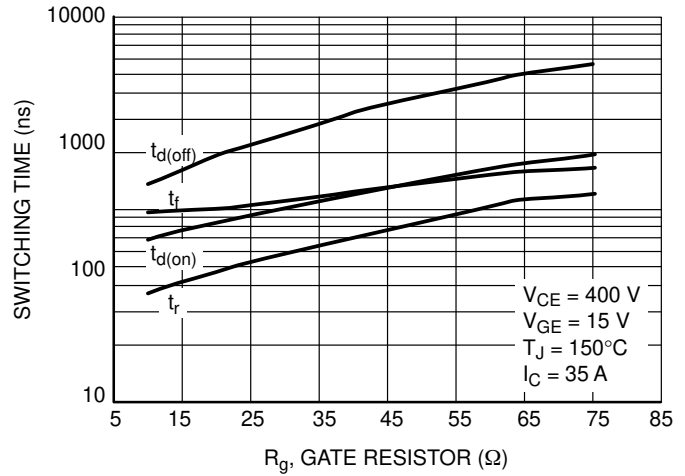


Figure 13. Switching Time vs. R_g

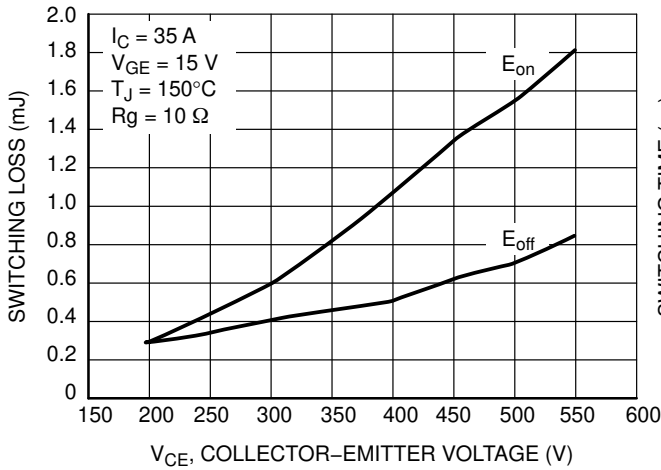


Figure 14. Switching Loss vs. V_{CE}

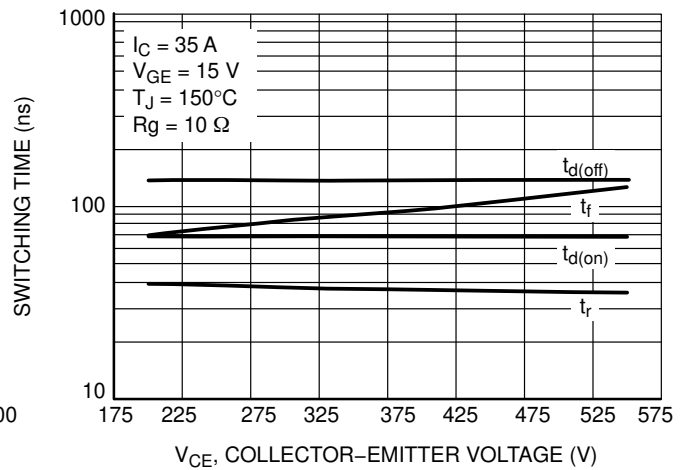


Figure 15. Switching Time vs. V_{CE}

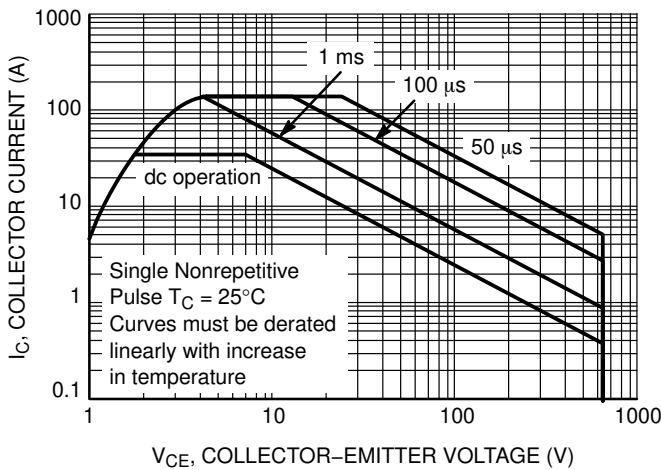


Figure 16. Safe Operating Area

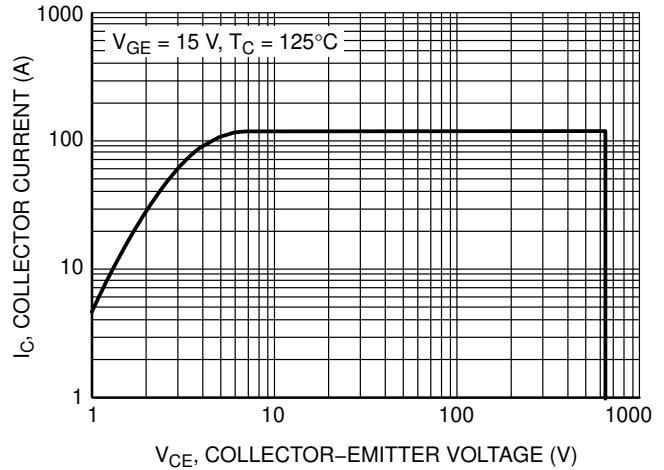


Figure 17. Reverse Bias Safe Operating Area

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TYPICAL CHARACTERISTICS

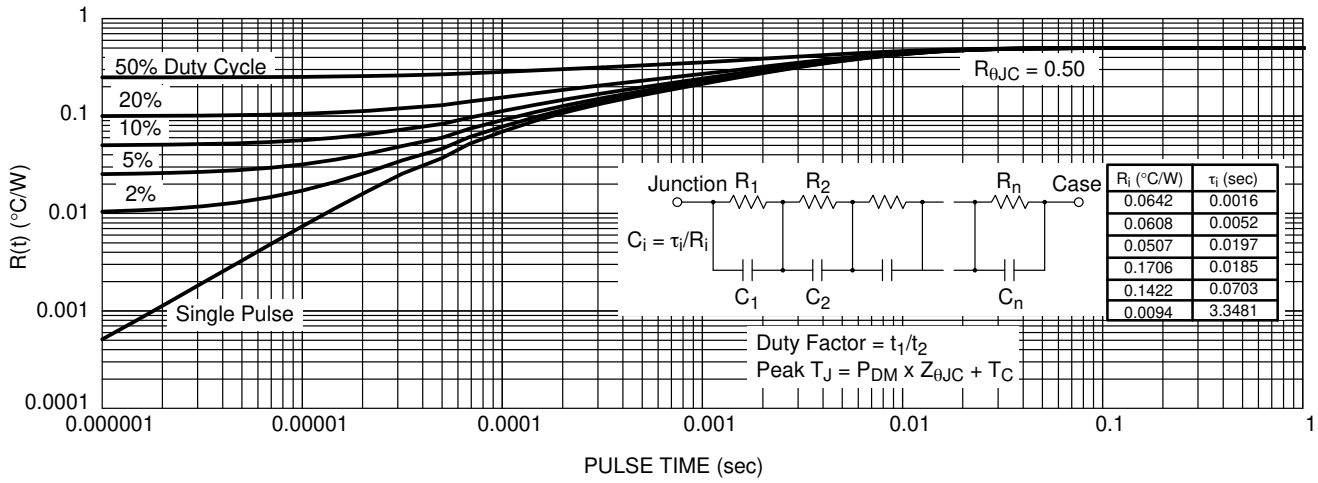


Figure 18. IGBT Transient Thermal Impedance

